Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/809,384	WANG, SUNG-FEI	
Examiner	Art Unit	
Ren P. Sandvik	2826	

	SEARCHED				
Class	Subclass	Date	Examiner		
257	737	2/28/2005	BPS		
257	738	2/28/2005	BPS		
257	778	2/28/2005	BPS		
257	786	2/28/2005	BPS		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
:					
,					
	<u> </u>				

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
searched for flip chips with reinforced bumps	3/1/2005	BPS
seached for flips chips with epoxy bumps and ring like bumps	3/1/2005	BPS